www.ti.com

# LM5114 Single 7.6A Peak Current Low-Side Gate Driver

Check for Samples: LM5114

#### **FEATURES**

- Independent Source and Sink Outputs for Controllable Rise and Fall Times
- +4V to +12.6V Single Power Supply
- 7.6A/1.3A Peak Sink/Source Drive Current
- 0.23Ω Open-drain Pull-down Sink Output
- 2Ω Open-drain Pull-up Source Output
- 12ns (Typical) Propagation Delay
- Matching Delay Time Between Inverting and Non-inverting Inputs
- TTL/CMOS Logic Inputs
- 0.68V Input Hysteresis
- Up to +14V Logic Inputs (Regardless of VDD Voltage)

- Low Input Capacitance: 2.5pF (Typical)
- -40°C to +125°C Operating Temperature Range
- Pin-to-Pin Compatible with MAX5048

### **APPLICATIONS**

- Boost Converters
- Flyback and Forward Converters
- Secondary Synchronous FETs Drive in Isolated Topologies
- Motor Control

### **DESCRIPTION**

The LM5114 is designed to drive low-side MOSFETs in boost type configurations or to drive secondary synchronous MOSFETs in isolated topologies. With strong sink current capability, the LM5114 can drive multiple FETs in parallel. The LM5114 also has the features necessary to drive low-side enhancement mode Gallium Nitride (GaN) FETs. The LM5114 provides inverting and non-inverting inputs to satisfy requirements for inverting and non-inverting gate drive in a single device type. The inputs of the LM5114 are TTL/CMOS Logic compatible and withstand the input voltages up to 14V regardless of the VDD voltage. The LM5114 has split gate outputs, providing flexibility to adjust the turn-on and turn-off strength independently. The LM5114 has fast switching speed and minimized propagation delays, facilitating high-frequency operation. The LM5114 is available in SOT-23 6-pin package and WQFN-6 package with an exposed pad to aid thermal dissipation.

### **Package**

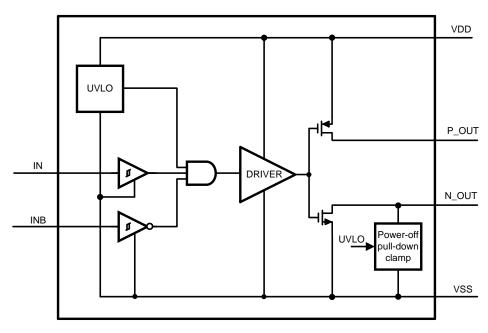
- SOT-23-6
- WQFN-6 (3mm x 3mm)

**A** 

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



# **Block Diagram**



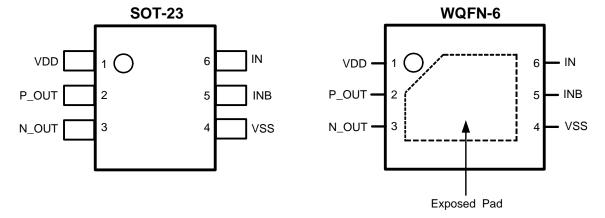
# **Input Options**

Base Part Number	Input Thresholds
LM5114A	CMOS
LM5114B	TTL

### **Truth Table**

IN	INB	P_OUT	N_OUT
L	L	OPEN	L
L	Н	OPEN	L
Н	L	Н	OPEN
Н	Н	OPEN	L

# **Connection Diagram**



Submit Documentation Feedback

Copyright © 2012, Texas Instruments Incorporated



#### **PIN DESCRIPTIONS**

Pin	No.	Nama	Description	Applications Information					
SOT-23-6	WQFN-6	Name	Description	Applications Information					
1	1	VDD	Gate drive supply	Locally decouple to VSS using low ESR/ESL capacitor located as close as possible to the IC.					
2	2	P_OUT	Source-current output	Connect to the gate of the MOSFET with a short, low inductance path. A gate resistor can be used to adjust the turn-on speed.					
3	3	N_OUT	Sink-current output	Connect to the gate of the MOSFET with a short, low inductance path. A gate resistor can be used to adjust the turn-off speed.					
4	4	VSS	Ground	All signals are referenced to this ground.					
5	5	INB	Inverting logic input	Connect to VSS when not used.					
6	6	IN	Non-inverting logic input	Connect to VDD when not used.					
	EP It is recommended that the exposed pad on the bottom of the package is soldered to ground plane on the PC board to aid thermal dissipation.								



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### Absolute Maximum Ratings (1)

-0.3 to 14V
-0.3 to 14V
-0.3 to VDD +0.3V
-0.3 to VDD +0.3V
+150°C
−55 to +150°C
2kV

<sup>(1)</sup> Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but does not guarantee specific performance limits. For guaranteed specifications and conditions, see the Electrical Characteristics.

### **Recommended Operating Conditions**

VDD	+4.0 to 12.6V
Junction Temperature	−40 to +125°C

#### **Electrical Characteristics**

Limits in standard type are for  $T_J$  = 25°C only; limits in boldface type apply over the junction temperature ( $T_J$ ) range of -40°C to +125°C. Minimum and Maximum limits are guaranteed through test, design, or statistical correlation. Typical values represent the most likely parametric norm at  $T_J$  = 25°C, and are provided for reference purposes only. Unless otherwise specified,  $V_{DD}$  = +12V <sup>(1)</sup>.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
POWER SI	JPPLY					
$V_{DD}$	VDD Operating Voltage		4.0		12.6	V
UVLO	VDD Undervoltage Lockout	VDD Rising	3.25	3.6	4.00	V
	VDD Undervoltage Lockout Hysteresis			0.4		V
	VDD Undervoltage lockout to Output delay time	VDD Rising		300		ns
I <sub>DD</sub>	VDD Quiescent Current	IN = INB = VDD		0.95	1.9	mA

<sup>(1)</sup> Min and Max limits are 100% production tested at 25°C. Limits over the operating temperature range are guaranteed through correlation using Statistical Quality Control (SQC) methods. Limits are used to calculate National's Average Outgoing Quality Level (AOQL).

Product Folder Links: LM5114



### **Electrical Characteristics (continued)**

Limits in standard type are for  $T_J = 25^{\circ}\text{C}$  only; limits in boldface type apply over the junction temperature  $(T_J)$  range of -40°C to +125°C. Minimum and Maximum limits are guaranteed through test, design, or statistical correlation. Typical values represent the most likely parametric norm at  $T_J = 25^{\circ}\text{C}$ , and are provided for reference purposes only. Unless otherwise specified,  $V_{DD} = +12V$  <sup>(1)</sup>.

Symbol	Parameter	Conditions		Min	Тур	Max	Units
N-CHANNE	EL OUTPUT						
		VDD = 10V,	$T_{J} = +25^{\circ}C$		0.23	0.26	Ω
R <sub>ON-N</sub>	Driver Outsid Desires - Delling Desires	$I_{N-OUT} = -100 \text{mA}$	$T_{J} = +125^{\circ}C$		0.38	0.43	Ω
(SOT-23- 6)	Driver Output Resistance – Pulling Down	VDD = 4.5V,	T <sub>J</sub> = +25°C		0.24	0.28	Ω
-,		$I_{N-OUT} = -100 \text{mA}$	TJ = +125°C		0.40	0.47	Ω
		VDD = 10V,	T <sub>J</sub> = +25°C		0.31	0.34	Ω
R <sub>ON-N</sub>	Driver Output Registeres Bulling Doug	$I_{N-OUT} = -100 \text{mA}$	T <sub>J</sub> = +125°C		0.46	0.51	Ω
R <sub>ON-N</sub> (WQFN-6)	Driver Output Resistance – Pulling Down	VDD = 4.5V,	T <sub>J</sub> = +25°C		0.32	0.36	Ω
		$I_{N-OUT} = -100 \text{mA}$	$T_{J} = +125^{\circ}C$		0.48	0.55	Ω
	Power-off Pull Down Resistance	$VDD = 0V$ , $I_{N-OUT} = -1$	10mA		3.3	10	Ω
	Power-off Pull Down Clamp Voltage	$VDD = 0V$ , $I_{N-OUT} = -1$	10mA		0.85	1.0	V
I <sub>LK-N</sub>	Output Leakage Current	N_OUT = VDD			6.85	20	μΑ
I <sub>PK-N</sub>	Peak Sink Current	C <sub>L</sub> = 10,000pF			7.6		Α
P-CHANNE	EL OUTPUT						
		VDD = 10V,	$T_J = +25^{\circ}C$		2.00	3.00	Ω
R <sub>ON-P</sub>	Driver Output Resistance – Pulling Up	$I_{P-OUT} = 50mA$	$T_{J} = +125^{\circ}C$		2.85	4.30	Ω
(SOT-23- 6)		VDD = 4.5V,	T <sub>J</sub> = +25°C		2.20	3.30	Ω
,		$I_{P-OUT} = 50mA$	$T_{J} = +125^{\circ}C$		3.10	4.70	Ω
		VDD = 10V,	T <sub>J</sub> = +25°C		2.08	3.08	Ω
R <sub>ON-P</sub>	Driver Output Resistance – Pulling Up	$I_{P-OUT} = 50mA$	$T_J = +125^{\circ}C$		2.93	4.38	Ω
(WQFN-6)		VDD = 4.5V,	$T_J = +25^{\circ}C$		2.28	3.38	Ω
		$I_{P-OUT} = 50mA$	$T_{J} = +125^{\circ}C$		3.18	4.78	Ω
I <sub>LK-P</sub>	Output Leakage Current	P_OUT = 0			0.001	10	uA
$I_{PK-P}$	Peak Source Current	CL = 10,000pF			1.3		Α
LOGIC INP	PUT						
$V_{IH}$	Logic 1 Input Voltage	LM5114A		0.67X VDD			V
		LM5114B	2.4			V	
$V_{IL}$	Logic 0 Input Voltage	LM5114A				0.33X VDD	V
12		LM5114B	LM5114B			0.8	V
	Landa Land Hartanasia	LM5114A			1.6		V
$V_{HYS}$	Logic-Input Hysteresis	LM5114B			0.68		V
	Logic-Input Current	INB = VDD or 0			0.001	10	uA
C <sub>IN</sub>	Input Capacitance				2.5		pF
THERMAL	RESISTANCE						
0	lunction to Ambient	SOT-23-6		90		°C/W	
$\theta_{JA}$	Junction to Ambient	WQFN-6			60		°C/W
SWITCHIN	G CHARACTERISTICS FOR VDD = +10V						
		C <sub>L</sub> = 1000pF		8		ns	
$t_R$	Rise Time	C <sub>L</sub> = 5000pF		45		ns	
		$C_L = 10,000pF$		82		ns	

Submit Documentation Feedback

Copyright © 2012, Texas Instruments Incorporated

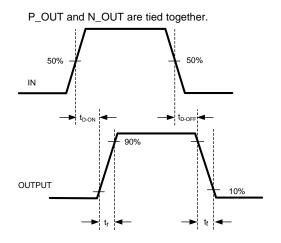


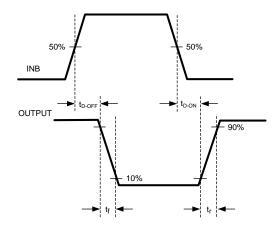
### **Electrical Characteristics (continued)**

Limits in standard type are for  $T_J = 25^{\circ}\text{C}$  only; limits in boldface type apply over the junction temperature ( $T_J$ ) range of -40°C to +125°C. Minimum and Maximum limits are guaranteed through test, design, or statistical correlation. Typical values represent the most likely parametric norm at  $T_J = 25^{\circ}\text{C}$ , and are provided for reference purposes only. Unless otherwise specified,  $V_{DD} = +12V$  <sup>(1)</sup>.

Symbol	Parameter	Cor	Conditions			Max	Units
		C <sub>L</sub> = 1000pF	C <sub>L</sub> = 1000pF				ns
t <sub>F</sub>	Fall Time	$C_L = 5000pF$			7.5		ns
		$C_L = 10,000pF$			12.5		ns
	Turn On Brangation Daloy	C 1000pF	LM5114A	5	12	30	ns
t <sub>D-ON</sub>	Turn-On Propagation Delay	$C_L = 1000pF$	LM5114B	6	12	25	ns
	Turn Off Proposition Polov	C 1000pF	LM5114A	5	12	30	ns
t <sub>D-OFF</sub> Turn-Off Propaga	Turn-Off Propagation Delay	$C_{L} = 1000pF$	LM5114B	6	12	25	ns
	Break-before-make Time						ns
SWITCHIN	G CHARACTERISTICS FOR VDD =	+4.5V					
		$C_{L} = 1000pF$	$C_L = 1000pF$ $C_L = 5000pF$				ns
t <sub>R</sub>	Rise Time	$C_L = 5000pF$					ns
		$C_L = 10,000pF$	C <sub>L</sub> = 10,000pF				ns
		C <sub>L</sub> = 1000pF			3.0		ns
t <sub>F</sub>	Fall Time	$C_L = 5000pF$	C <sub>L</sub> = 5000pF				ns
		$C_L = 10,000pF$		11.3		ns	
	Turn On Brangation Daloy	C 1000pF	LM5114A	5	17	36	ns
t <sub>D-ON</sub>	Turn-On Propagation Delay	$C_{L} = 1000pF$	LM5114B	8	14	27	ns
	Turn Off Drangation Dalay	C 1000pF	LM5114A	5	17	36	ns
t <sub>D-OFF</sub>	Turn-Off Propagation Delay	$C_L = 1000pF$	LM5114B	8	14	27	ns
	Break-Before-Make Time		·		4.2		ns

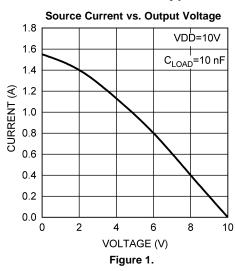
### **TIMING DIAGRAM**

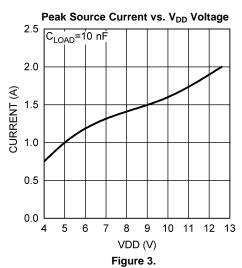


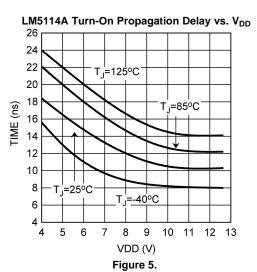


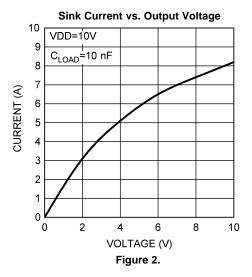


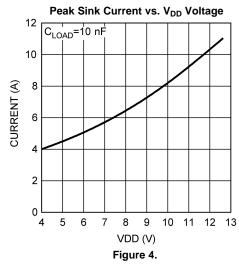
### **Typical Performance Characteristics**

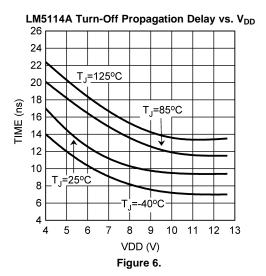






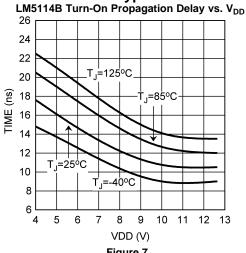


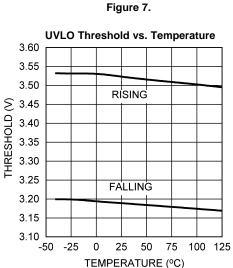


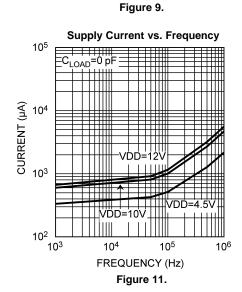


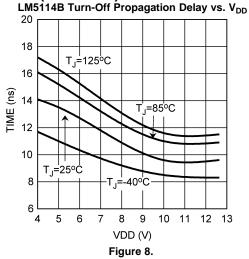


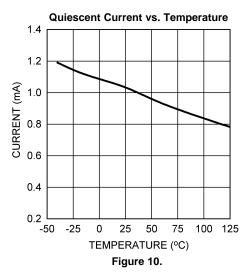
# **Typical Performance Characteristics (continued)**

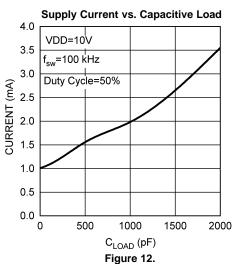






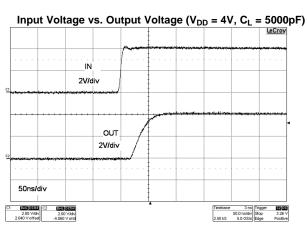








#### **Typical Performance Characteristics (continued)** Input Voltage



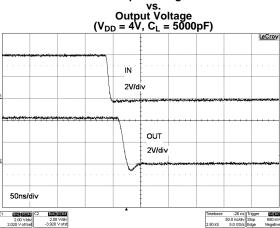


Figure 13.

Figure 14.

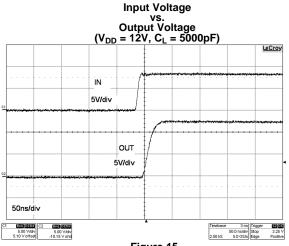


Figure 15.

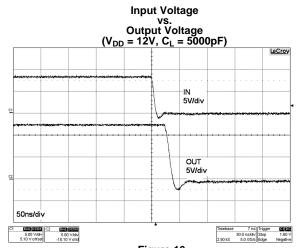


Figure 16.

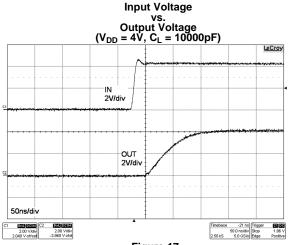


Figure 17.

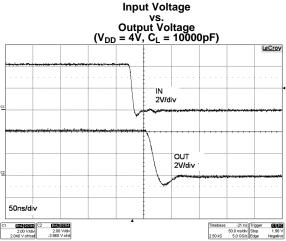
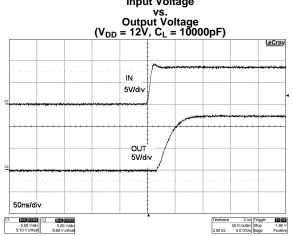


Figure 18.

Submit Documentation Feedback







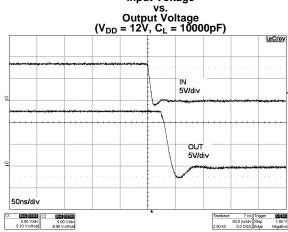


Figure 19. Figure 20.



### **TYPICAL APPLICATIONS**

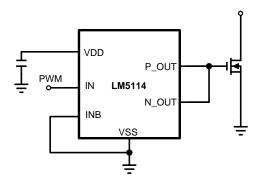


Figure 21. Non-inverting Application

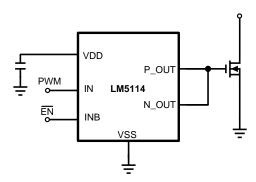


Figure 22. Non-Inverting Application with Enable Pin

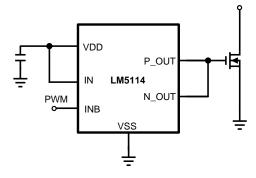


Figure 23. Inverting Application

Submit Documentation Feedback



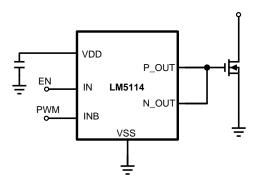


Figure 24. Inverting Application with Enable Pin

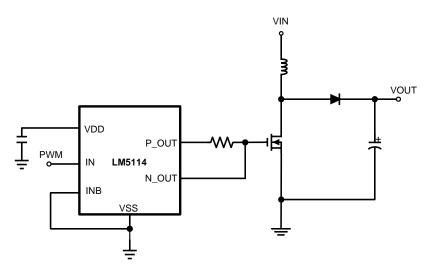


Figure 25. A Simplified Boost Converter

#### **Detailed Operating Description**

The LM5114 is designed to drive low-side MOSFETs in boost type configurations or to drive secondary synchronous MOSFETs in isolated topologies. The LM5114 offers both inverting and non-inverting inputs to satisfy requirements for inverting and non-inverting gate drive in a single device type. Inputs of the LM5114 are TTL Logic compatible and can withstand the input voltages up to 14V regardless of the VDD voltage. This allows inputs of the LM5114 to be connected directly to most PWM controllers. The split outputs of the LM5114 offer flexibility to adjust the turn-on and turn-off speed independently by adding additional impedance in either the turn-on path and/or the turn-off path.

The LM5114 includes an under-voltage lockout (UVLO) circuit. When the VDD voltage is below the UVLO threshold voltage, the IN and INB inputs are ignored, and if there is sufficient VDD voltage, the output NMOS is turned on to pull the N\_OUT low. In addition, the LM5114 has an internal PNP transistor in parallel with the output NMOS. Under the UVLO condition, the PNP transistor will be on and clamp the N\_OUT voltage below 1V. This feature ensures the N\_OUT remaining low when VDD voltage is not sufficient to enhance the output NMOS.

The LM5114 has the features necessary to drive low-side enhancement mode GaN FETs. Due to the fast switching speed and relatively low gate voltage of enhancement mode GaN FETs, PCB layout is crucial to achieve reliable operation. Refer to Layout Considerations for details.

Product Folder Links: LM5114



### **Power Dissipation**

It is important to keep the power consumption of the driver below the maximum power dissipation limit of the package at the operating temperature. The total power dissipation of the LM5114 is the sum of the gate charge losses and the losses in the driver due to the internal CMOS stages used to buffer the output as well as the power losses associated with the quiescent current.

The gate charge losses can be calculated with the total input gate charge as follows.

$$P_{g} = Q_{g} \times V_{DD} \times F_{sw}$$
(1)

Or

$$P_g = C_{LOAD} \times V_{DD}^2 \times F_{SW}$$
 (2)

Where F<sub>sw</sub> is switching frequency.

The power dissipation associated with the internal circuit operation of the driver can be estimated with the characterization curves of the LM5114. For a given ambient temperature, the maximum allowable power loss of the IC can be defined as

$$P = \frac{\left( T_{J} - T_{A} \right)}{\theta_{JA}}$$
(3)

Where P is the total power dissipation of the driver.

### **Layout Considerations**

Attention must be given to board layout when using LM5114. Some important considerations include:

- 1. The first priority in designing the layout of the driver is to confine the high peak currents that charge and discharge the FETs gate into a minimal physical area. This will decrease the loop inductance and minimize noise issues on the gate.
- 2. To reduce the loop inductance, the driver should be placed as close as possible to the FETs. The gate trace to and from the FETs are recommended to be placed closely side by side, or directly on top of one another.
- 3. A low ESR/ESL ceramic capacitor must be connected close to the IC, between VDD and VSS pins to support the high peak current being drawn from VDD during turn-on of the FETs. It is most desirable to place the VDD decoupling capacitor on the same side of the PC board as the driver. The inductance of via holes can impose excessive ringing on the IC pins.
- 4. The parasitic source inductance, along with the gate capacitor and the driver pull-down path, can form a LCR resonant tank, resulting in gate voltage oscillations. An optional resistor or ferrite bead can be used to damp the ringing.

Submit Documentation Feedback

Copyright © 2012, Texas Instruments Incorporated

20-Feb-2013

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish		Op Temp (°C)		Samples
LM5114AMF/NOPB	ACTIVE	SOT-23	DBV	6	1000	Green (RoHS & no Sb/Br)	SN	(3) Level-3-260C-168 HR	-40 to 125	SL2A	Samples
LM5114AMF/S7003109	ACTIVE	SOT-23	DBV	6	1000	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	-40 to 125		Samples
LM5114AMFX/NOPB	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	-40 to 125	SL2A	Samples
LM5114AMFX/S7003103	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	-40 to 125	SL2A	Samples
LM5114ASD/NOPB	ACTIVE	WSON	NGG	6	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	5114A	Samples
LM5114ASDX/NOPB	ACTIVE	WSON	NGG	6	4500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	5114A	Samples
LM5114BMF/NOPB	ACTIVE	SOT-23	DBV	6	1000	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	-40 to 125	SJ4B	Samples
LM5114BMF/S7003110	ACTIVE	SOT-23	DBV	6	1000	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	-40 to 125		Samples
LM5114BMFX/NOPB	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	-40 to 125	SJ4B	Samples
LM5114BMFX/S7003094	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	-40 to 125	SJ4B	Samples
LM5114BSD/NOPB	ACTIVE	WSON	NGG	6	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	5114B	Samples
LM5114BSDX/NOPB	ACTIVE	WSON	NGG	6	4500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	5114B	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



### PACKAGE OPTION ADDENDUM

20-Feb-2013

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above. **Green** (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight

in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Only one of markings shown within the brackets will appear on the physical device.

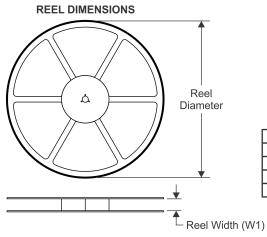
**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# PACKAGE MATERIALS INFORMATION

www.ti.com 21-Feb-2013

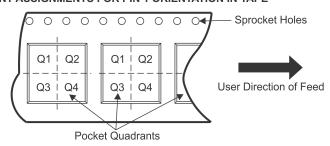
### TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

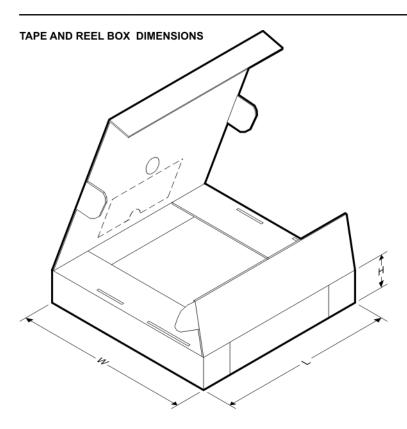
### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

"All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM5114AMF/NOPB	SOT-23	DBV	6	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM5114AMF/S7003109	SOT-23	DBV	6	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q2
LM5114AMFX/NOPB	SOT-23	DBV	6	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM5114AMFX/S7003103	SOT-23	DBV	6	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q2
LM5114ASD/NOPB	WSON	NGG	6	1000	178.0	12.4	3.3	3.3	1.0	8.0	12.0	Q1
LM5114ASDX/NOPB	WSON	NGG	6	4500	330.0	12.4	3.3	3.3	1.0	8.0	12.0	Q1
LM5114BMF/NOPB	SOT-23	DBV	6	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM5114BMF/S7003110	SOT-23	DBV	6	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q2
LM5114BMFX/NOPB	SOT-23	DBV	6	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM5114BMFX/S7003094	SOT-23	DBV	6	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q2
LM5114BSD/NOPB	WSON	NGG	6	1000	178.0	12.4	3.3	3.3	1.0	8.0	12.0	Q1
LM5114BSDX/NOPB	WSON	NGG	6	4500	330.0	12.4	3.3	3.3	1.0	8.0	12.0	Q1

www.ti.com 21-Feb-2013

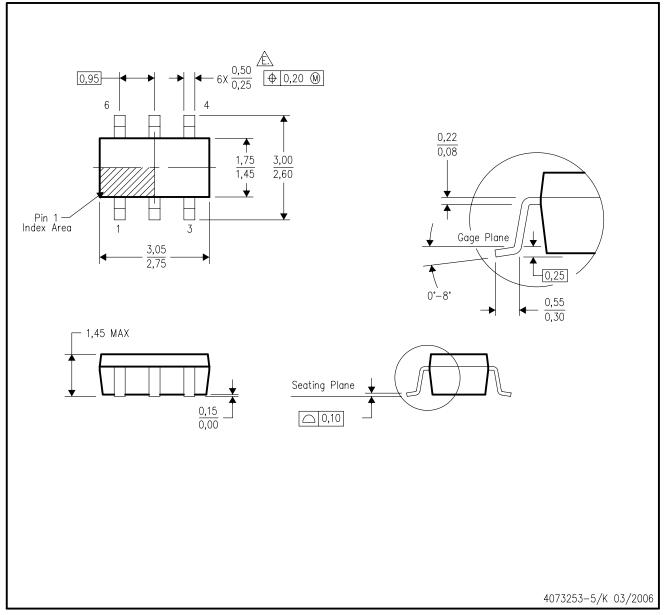


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM5114AMF/NOPB	SOT-23	DBV	6	1000	203.0	190.0	41.0
LM5114AMF/S7003109	SOT-23	DBV	6	1000	203.0	190.0	41.0
LM5114AMFX/NOPB	SOT-23	DBV	6	3000	203.0	190.0	41.0
LM5114AMFX/S7003103	SOT-23	DBV	6	3000	203.0	190.0	41.0
LM5114ASD/NOPB	WSON	NGG	6	1000	203.0	190.0	41.0
LM5114ASDX/NOPB	WSON	NGG	6	4500	349.0	337.0	45.0
LM5114BMF/NOPB	SOT-23	DBV	6	1000	203.0	190.0	41.0
LM5114BMF/S7003110	SOT-23	DBV	6	1000	203.0	190.0	41.0
LM5114BMFX/NOPB	SOT-23	DBV	6	3000	203.0	190.0	41.0
LM5114BMFX/S7003094	SOT-23	DBV	6	3000	203.0	190.0	41.0
LM5114BSD/NOPB	WSON	NGG	6	1000	203.0	190.0	41.0
LM5114BSDX/NOPB	WSON	NGG	6	4500	349.0	337.0	45.0

# DBV (R-PDSO-G6)

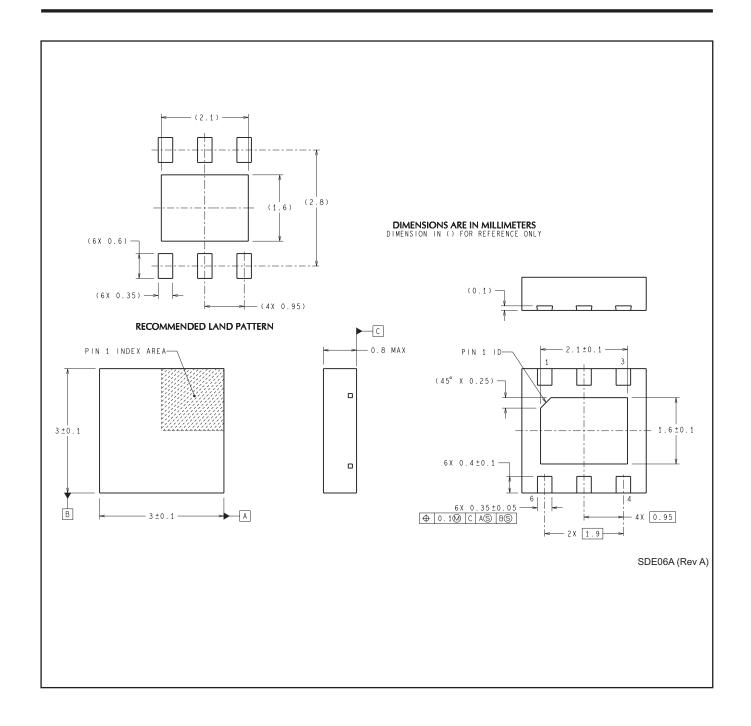
# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- Falls within JEDEC MO-178 Variation AB, except minimum lead width.





#### IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive Communications and Telecom **Amplifiers** amplifier.ti.com www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps

DSP **Energy and Lighting** dsp.ti.com www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical logic.ti.com Logic Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers <u>microcontroller.ti.com</u> Video and Imaging <u>www.ti.com/video</u>

RFID www.ti-rfid.com

OMAP Applications Processors <a href="www.ti.com/omap">www.ti.com/omap</a> TI E2E Community <a href="e2e.ti.com">e2e.ti.com</a>

Wireless Connectivity <u>www.ti.com/wirelessconnectivity</u>